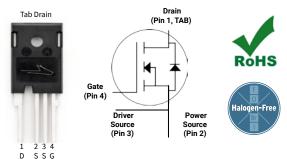


C3M0075120K-A

1200V 75mohm Silicon Carbide Power MOSFET N-Channel Enhancement Mode

Features

- 3rd generation Silicon Carbide (SiC) MOSFET technology
- Optimized package with separate driver source pin
- 8mm of creepage distance between drain and source
- High blocking voltage with low on-resistance
- High-speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery (Q_{rr})
- Halogen free, RoHS compliant



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Part Number	Package	Marking
C3M0075120K-A	TO-247-4	C3M0075120K-A

Applications

- Renewable energy
- EV battery chargers
- High voltage DC/DC converters
- Switch Mode Power Supplies

- Benefits
- Reduce switching losses and minimize gate ringing
- Higher system efficiency
- Reduce cooling requirements
- Increase power density
- Increase system switching frequency

Key Parameters

Parameter	Symbol	Min.	Тур.	Мах	Unit	Conditions	Note
Drain - Source Voltage	V _{DS}			1200		T _c = 25°C	
Maximum Gate - Source Voltage	$V_{GS(max)}$	-8		+19	v	Transient	
Operational Gate-Source Voltage	V _{GS op}		-4/15			Static	Note 1
DC Continuous Drain Current	I _D			32		$V_{gs} = 15 V, T_c = 25 °C, T_J \le 175 °C$	Fig. 19
DC Continuous Drain Current				23	A	$V_{GS} = 15 \text{ V}, \text{ T}_{C} = 100 \text{ °C}, \text{ T}_{J} \le 175 \text{ °C}$	Note 2
Pulsed Drain Current	I _{DM}			123		t_{Pmax} limited by T_{jmax} $V_{GS} = 15V, T_{C} = 25 °C$	Fig. 22
Power Dissipation	P _D			136	w	T _c = 25°C, T _J = 175°C	Fig. 20
Operating Junction and Storage Temperature	T _J , T _{stg}			-40 to +175	°C		
Solder Temperature	TL			260		According to JEDEC J-STD-020	
Mounting Torque	M _s			1 8.8	N-m lbf-in	M3 or 6-32 screw	

Note (1): Recommended turn-on gate voltage is 15V with ±5% regulation tolerance, see Application Note PRD-04814 for additional details Note (2): Verified by design

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C3M0075120K-A

Electrical Characteristics ($T_c = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Min.	Тур.	Max.	Unit	Test Conditions	Note
Drain-Source Breakdown Voltage	V _{(BR)DSS}	1200	-	-		$V_{GS} = 0 V, I_{D} = 100 \mu A$	
Gate Threshold Voltage	N	1.8	2.5	3.6	V	$V_{DS} = V_{GS}, I_D = 5 \text{ mA}, T_J = 25^{\circ}\text{C}$	Fig. 11
Gate Threshold Voltage	- V _{GS(th)}	_	2.2	_		$V_{DS} = V_{GS}$, $I_{D} = 5$ mA, $T_{J} = 175^{\circ}C$	Fig.11
Zero Gate Voltage Drain Current	I _{DSS}	_	1	50	μA	$V_{DS} = 1200 V, V_{GS} = 0 V$	
Gate-Source Leakage Current	I _{GSS}	_	10	250	nA	$V_{GS} = 15 V, V_{DS} = 0 V$	
Drain-Source On-State Resistance	_	_	75	90		V _{GS} = 15 V, I _D = 20 A, T _J =25°C	Fig. 4, 5, 6
Drain-Source On-State Resistance	- R _{DS(on)}	_	- 120 - mΩ		mΩ	V _{GS} = 15 V, I _D = 20 A, T _J =175°C	Fig. 4, 5, 6
Transconductance	-		12		6	$V_{DS} = 20 \text{ V}, I_{DS} = 20 \text{ A}, T_{J} = 25^{\circ}\text{C}$	Fig. 7
Transconductance	g _{fs}	_	13	-	S	V _{DS} = 20 V, I _{DS} = 20 A, T _J =175°C	Fig.7
Input Capacitance	C _{iss}	_	1390	-			
Output Capacitance	Coss	_	58	-	pF	$V_{GS} = 0 V, V_{DS} = 1000 V$ f = 1 Mhz	Fig.
Reverse Transfer Capacitance	C _{rss}	_	2	-		$V_{AC} = 25 \text{ mV}$	11,10
Output Capacitance Stored Energy	E _{oss}	_	33	-			Fig. 16
Turn-On Switching Energy (Body Diode FWD)	Eon	_	270	-	μJ	$V_{DS} = 800 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}, I_{D} = 20 \text{ A},$	Fig.
Turn Off Switching Energy (Body Diode FWD)	E _{off}	_	77	-		$R_{G(ext)} = 0 \Omega, L = 156 \mu H, T_J = 150^{\circ}C$	26, 29
Turn-On Delay Time	t _{d(on)}	_	30	-		$V_{DD} = 800 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}$	Fig. 27, 28
Rise Time	tr	_	14	-		$I_D = 20 \text{ A}, R_{G(ext)} = 0 \Omega,$ Timing relative to V_{DS}	
Turn-Off Delay Time	t _{d(off)}	_	38	-	ns		
Fall Time	t _f	_	10	-		Inductive load	
Internal Gate Resistance	R _{G(int)}	_	9	-	Ω	<i>f</i> = 1 MHz, V _{AC} = 25 mV	
Effective Output Capacitance (Energy Related)	C _{O(er)}	_	67	_			Note 3
Effective Output Capacitance (Time Related)	C _{O(tr)}	_	96	_	pF	V _{GS} =0V, V _{DS} =0800V	
Gate to Source Charge	Q _{gs}	_	17	_		V _{DS} = 800 V, V _{GS} = -4 V/15 V	
Gate to Drain Charge	Q _{gd}	_	18	_	nC	$I_{\rm D} = 20 {\rm A}$	Fig. 12
Total Gate Charge	Qg	_	53	_		Per IEC60747-8-4 pg 21	

Reverse Diode Characteristics ($T_c = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Тур.	Max.	Unit	Test Conditions	Note
Diada Farward Valtaga		4.5	_	v	$V_{GS} = -4 V$, $I_{SD} = 10 A$	Fig. 8,
Diode Forward Voltage	V _{SD}	4.0	_	V	$V_{GS} = -4 \text{ V}, \text{ I}_{SD} = 10 \text{ A}, \text{ T}_{J} = 175^{\circ}\text{C}$	9,10
Continuous Diode Forward Current	Is	-	26		$y = 4y = -25^{\circ}$	
Diode Pulse Current	I _{SM}	-	123	A	$V_{GS} = -4 V, T_{J} = 25^{\circ}C$	
Reverse Recovery Time	t _{rr}	20	_	nS	V_{GS} = -4 V, pulse width t _P limited by T _{j max}	
Reverse Recovery Charge	Q _{rr}	254	_	nC	$V_{GS} = -4 V, I_{SD} = 20 A, V_{R} = 800 V$	
Peak Reverse Recovery Current	Irrm	18	_	A	dif/dt = 3600 A/µs, T」 = 150°C	

Thermal Characteristics

Parameter	Symbol	Max.	Unit	Note
Thermal Resistance from Junction to Case	$R_{ extsf{ heta}JC}$	1.1	°C/W	Fig. 21

Note:

 3 C_{o(er)}, a lumped capacitance that gives the same stored energy as Coss while Vds is rising from 0 to 800V C_{o(tr)}, a lumped capacitance that gives the same charging time as Coss while Vds is rising from 0 to 800V



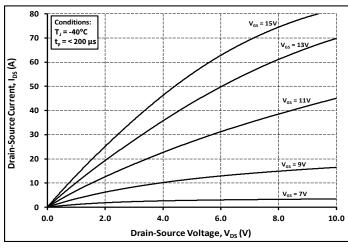
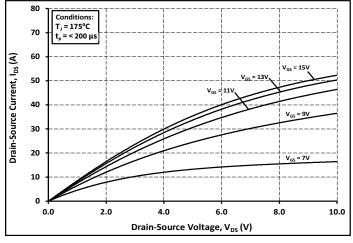
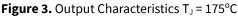
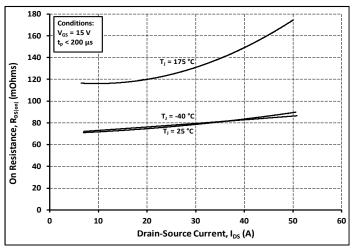
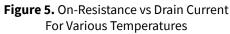


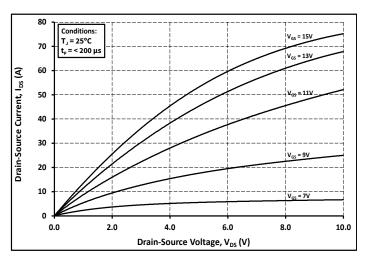
Figure 1. Output Characteristics T_J = -40°C

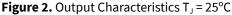












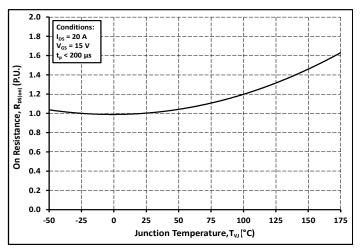
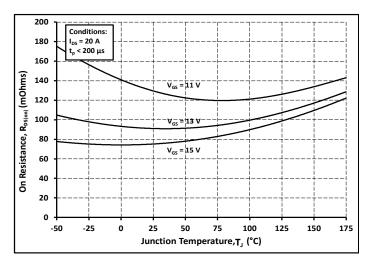
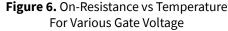


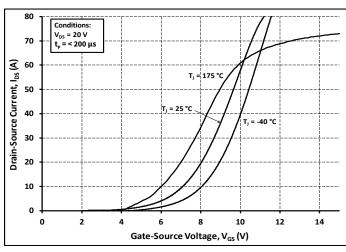
Figure 4. Normalized On-Resistance vs Temperature

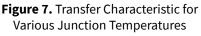




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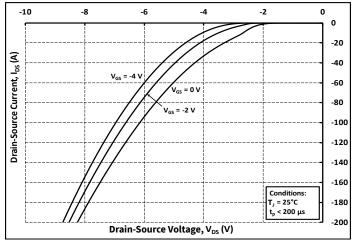
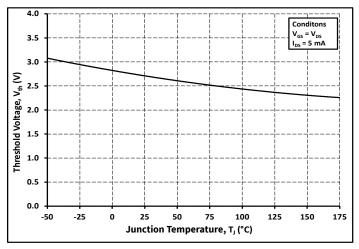
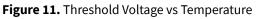


Figure 9. Body Diode Characteristic at 25°C





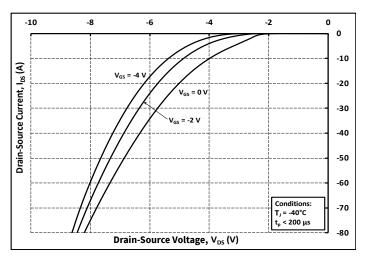


Figure 8. Body Diode Characteristic at -40°C

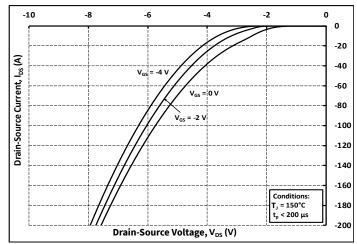
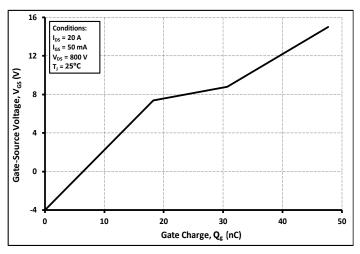
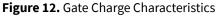


Figure 10. Body Diode Characteristic at 175°C







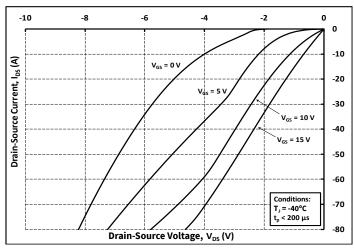


Figure 13. 3rd Quadrant Characteristic at -40°C

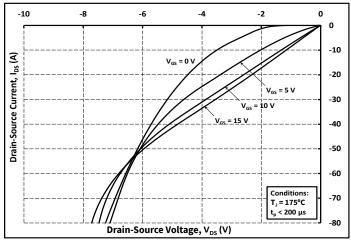
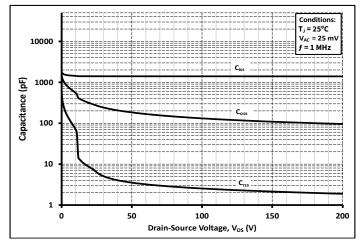
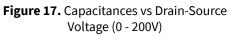


Figure 15. 3rd Quadrant Characteristic at 175°C





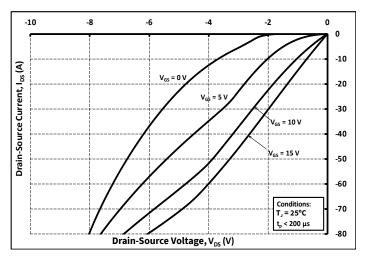


Figure 14. 3rd Quadrant Characteristic at 25°C

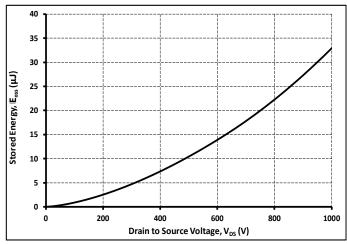
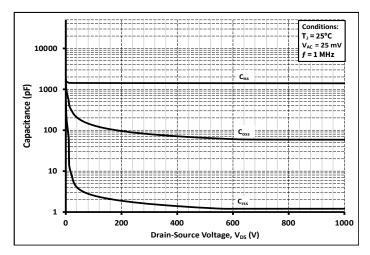
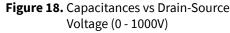


Figure 16. Output Capacitor Stored Energy

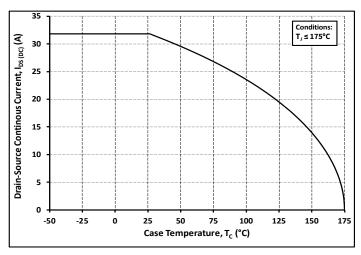




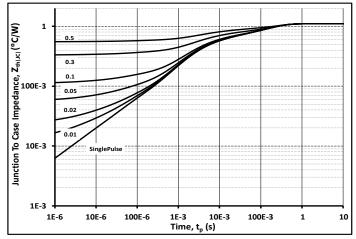
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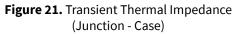
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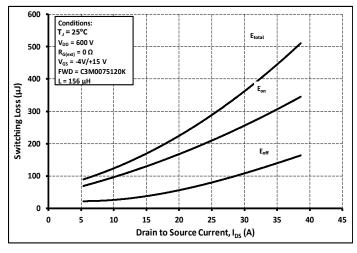


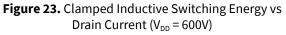












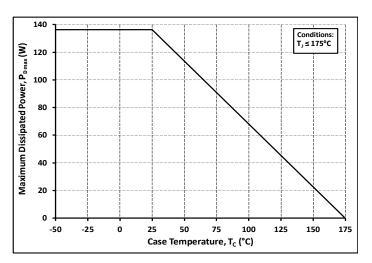


Figure 20. Maximum Power Dissipation Derating vs Case Temperature

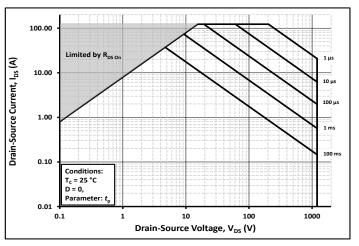


Figure 22. Safe Operating Area

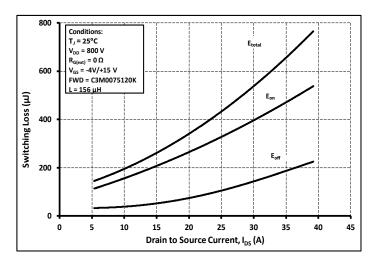


Figure 24. Clamped Inductive Switching Energy vs Drain Current (V_{DD} = 800V)

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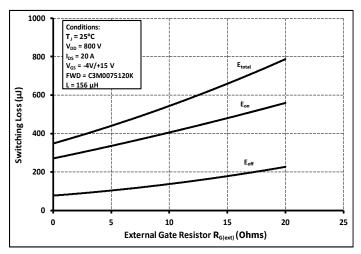


Figure 25. Clamped Inductive Switching Energy vs $R_{G(ext)}$

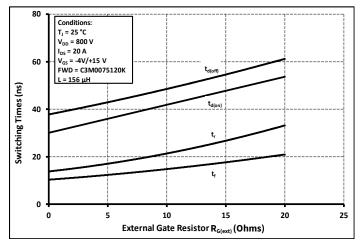


Figure 27. Switching Times vs. $R_{G(ext)}$

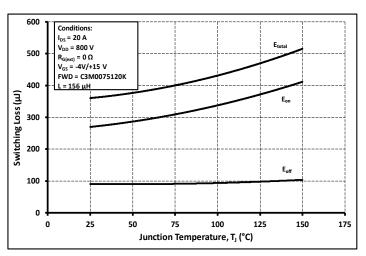


Figure 26. Clamped Inductive Switching Energy vs Temperature

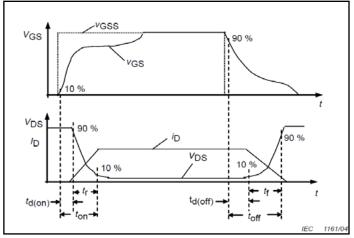


Figure 28. Switching Times Definition

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Test Circuit Schematic

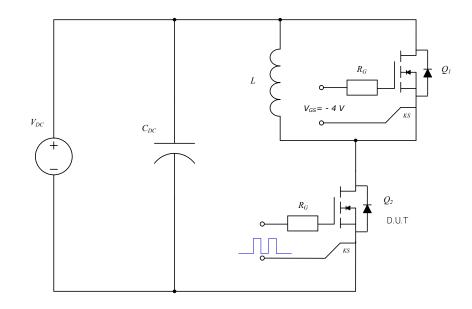


Figure 29. Clamped Inductive Switching Waveform Test Circuit

Note:

Turn-off and Turn-on switching energy and timing values measured using SiC MOSFET Body Diode as shown above.

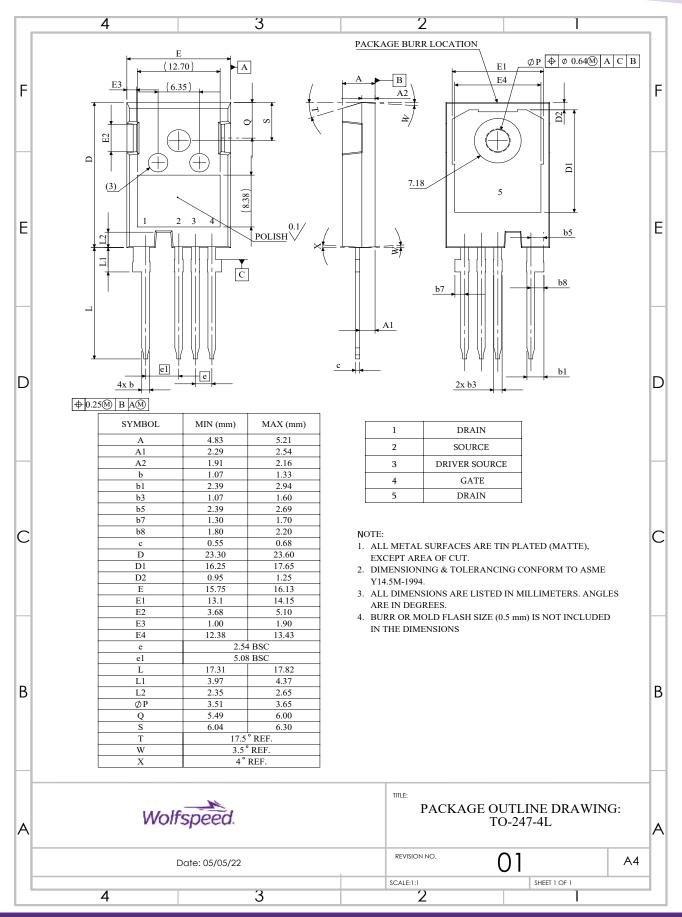
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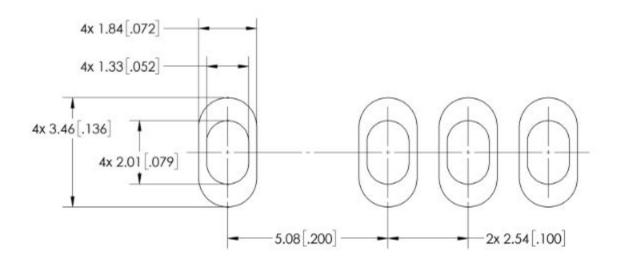
Package Dimensions – Package TO-247-4L



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Recommended Solder Pad Layout



Rev. 01, August 2023

Related Links



- SPICE Models
- SiC MOSFET Isolated Gate Driver reference design
- SiC MOSFET Evaluation Board

Revision History

Document Version	Date of Release	Description of Changes
1	August-2023	Inital Release



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The Silicon Carbide MOSFET module switches at speeds beyond what is customarily associated with IGBT-based modules. Therefore, special precautions are required to realize optimal performance. The interconnection between the gate driver and module housing needs to be as short as possible. This will afford optimal switching time and avoid the potential for device oscillation. Also, great care is required to insure minimum inductance between the module and DC link capacitors to avoid excessive VDS overshoot.

RoHS Compliance

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS2), as implemented January 2, 2013. RoHS Declarations for this product can be obtained from your Wolfspeed representative or from the Product Documentation sections of www.wolfspeed.com.

REACh Compliance

REACh substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact your Wolfspeed representative to ensure you get the most up-to-date REACh SVHC Declaration. REACh banned substance information (REACh Article 67) is also available upon request.

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